Search Notes

Application/Control N	No. Applicant(s)/Pater Reexamination	Applicant(s)/Patent under Reexamination AOKI, TAKAHIRO	
10/628,477	AOKI, TAKAHIRO		
Examiner	Art Unit		
May Liou	2624		

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INTERFERENCE SEARCHED				
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DATE	EXMR
10/15/2006	AL
10/19/2006	AL
10/23/2006	AL
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4/20/2007	AL
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